

NLX1G99

Configurable Multifunction Gate

The NLX1G99 MiniGate™ is an advanced high-speed CMOS multifunction gate with a 3-state output. With the output enable input (\overline{OE}) at High, the output is disabled and is kept at high impedance. With the output enable input (\overline{OE}) at Low, the device can be configured for logic functions such as MUX, AND, OR, NAND, NOR, XOR, XNOR, INVERT and BUFFER, depending on the combination of the 4-bit input. The device has Schmitt-trigger inputs, thereby enhancing noise immunity.

The NLX1G99 input and output structures provide protection when voltages up to 7.0 V are applied, regardless of the supply voltage.

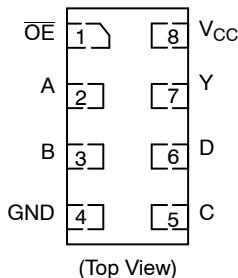
Features

- High Speed: $t_{PD} = 6.7$ ns (Max) @ $V_{CC} = 3.3$ V
- Low Power Dissipation: $I_{CC} = 1 \mu A$ (Max) at $T_A = 25^\circ C$
- Power Down Protection Provided on inputs
- Balanced Propagation Delays
- Overtoltage Tolerant (OVT) Input and Output Pins
- Ultra-Small Packages
- These are Pb-Free Devices

PIN ASSIGNMENT

| | |
|---|-----------------|
| 1 | \overline{OE} |
| 2 | A |
| 3 | B |
| 4 | GND |
| 5 | C |
| 6 | D |
| 7 | Y |
| 8 | V_{CC} |

PIN ASSIGNMENTS



ON Semiconductor®

<http://onsemi.com>

MARKING DIAGRAMS

| | | |
|--|---|--|
| | ULLGA8 1.45 x 1.0 CASE 613AA | |
| | ULLGA8 1.6 x 1.0 CASE 613AB | |
| | ULLGA8 1.95 x 1.0 CASE 613AC | |
| | UDFN8 1.45 x 1.0 CASE 517BZ | |
| | UDFN8 1.6 x 1.0 CASE 517BY | |
| | UDFN8 1.95 x 1.0 CASE 517CA | |

AA or E = Specific Device Code

M = Date Code

▪ = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 12 of this data sheet.

FUNCTION DIAGRAM

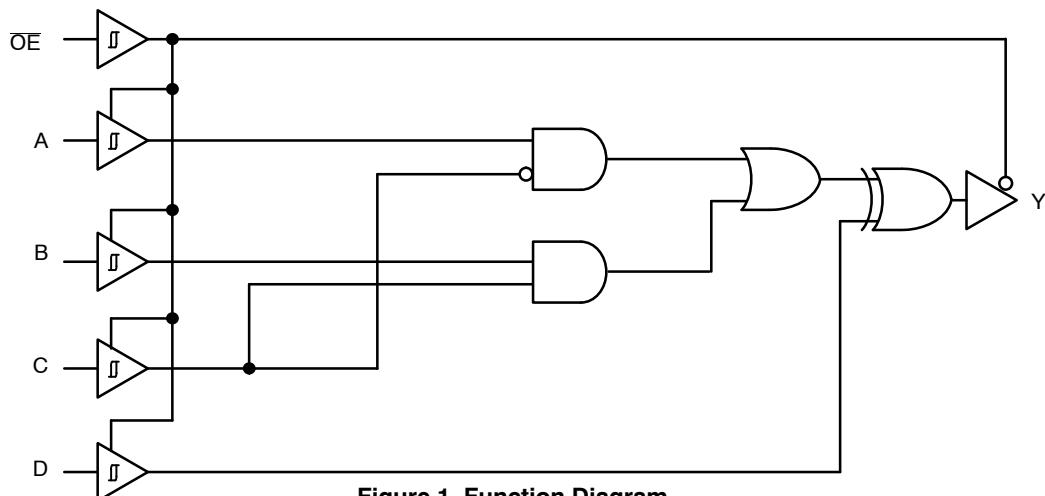


Figure 1. Function Diagram

FUNCTION TABLE*

| INPUT | | | | | OUTPUT | |
|-------|--------|---|--------|---|--------|--|
| OE | D | C | B | A | Y | |
| L | L | L | L | L | L | |
| | L | L | L | H | H | |
| | L | L | H | L | L | |
| | L | L | H | H | H | |
| | L | H | L | L | L | |
| | L | H | L | H | L | |
| | L | H | H | L | H | |
| | L | H | H | H | H | |
| | H | L | L | L | H | |
| | H | L | L | H | L | |
| H | H or L | | H or L | | Z | |

*To select a logic function, please refer to "Logic Configurations" section.

| FUNCTION SELECTION | LOGIC CONFIGURATION PAGE |
|------------------------|--------------------------|
| 3-State Buffers | 3 |
| 3-State Inverters | 3 |
| 3-State MUXes | 3 |
| 3-State AND / OR / NOR | 4 |
| 3-State NAND / OR | 5 |
| 3-State XOR/XNOR | 6 |

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LOGIC CONFIGURATIONS

3-State Buffer Functions Available

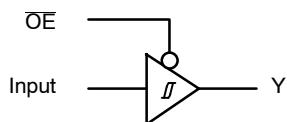


Figure 2.

| Function | OE | A | B | C | D |
|----------------|----|---|---|--|---|
| 3-State Buffer | L | Input H or L L H H H or L L | H or L Input H L H or L L L | L H Input Input L H H or L | L L L H Input Input Input |

3-State Inverter Functions Available

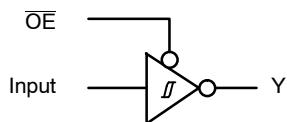


Figure 3.

| Function | OE | A | B | C | D |
|----------------|----|--|---|--|---|
| 3-State Buffer | L | Input X L H H H or L H | H or L Input H L H or L H H | L H Input Input L H H or L | H H H L Input Input Input |

3-State MUX Functions Available

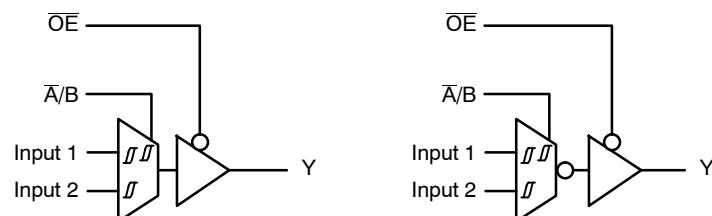


Figure 4.

| Function | OE | A | B | C | D |
|--|----|--|--|--|------------------|
| 3-State 2-to-1 3-State 2-to-1 3-State 2-to-1, Inverted Out 3-State 2-to-1, Inverted Out | L | Input 1 Input 2 Input 1 Input 2 | Input 2 Input 1 Input 2 Input 1 | Input 1 or Input 2 Input 2 or Input 1 Input 1 or Input 2 Input 2 or Input 1 | L L H H |

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3-State AND/NOR/OR Function Available

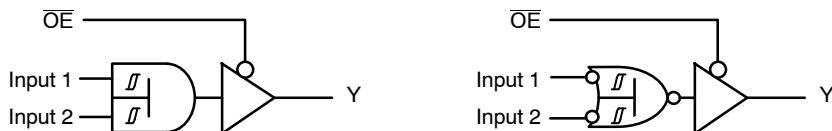


Figure 5.

| No. of Inputs | AND/NAND Function | OR/NOR Function | \overline{OE} | A | B | C | D |
|---------------|----------------------------|----------------------------|-----------------|--------|--------------------|--------------------|--------|
| 2 2 | 3-State AND 3-State AND | 3-State NOR 3-State NOR | L | L L | Input 1 Input 2 | Input 2 Input 1 | L L |

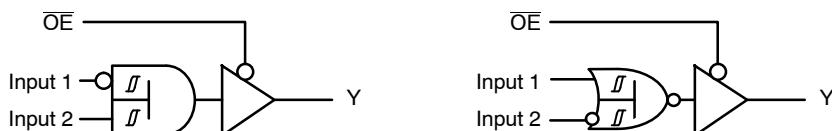


Figure 6.

| No. of Inputs | AND/NAND Function | OR/NOR Function | \overline{OE} | A | B | C | D |
|---------------|----------------------------|----------------------------|-----------------|--------------|--------------|--------------------|--------|
| 2 2 | 3-State AND 3-State AND | 3-State NOR 3-State NOR | L | Input 2 H | L Input 1 | Input 1 Input 2 | L H |

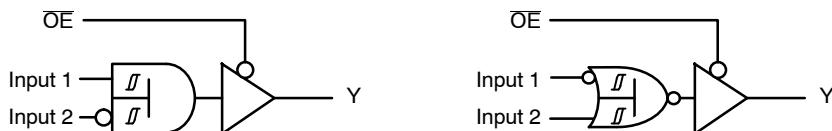


Figure 7.

| No. of Inputs | AND/NAND Function | OR/NOR Function | \overline{OE} | A | B | C | D |
|---------------|----------------------------|----------------------------|-----------------|--------------|--------------|--------------------|--------|
| 2 2 | 3-State AND 3-State AND | 3-State NOR 3-State NOR | L | Input 1 H | L Input 2 | Input 2 Input 1 | L H |

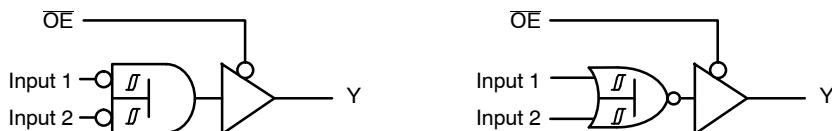


Figure 8.

| No. of Inputs | AND/NAND Function | OR/NOR Function | \overline{OE} | A | B | C | D |
|---------------|----------------------------|--------------------------|-----------------|--------------------|--------|--------------------|--------|
| 2 2 | 3-State AND 3-State AND | 3-State OR 3-State OR | L | Input 1 Input 2 | H H | Input 2 Input 1 | L L |

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3-State NAND/OR Function Available

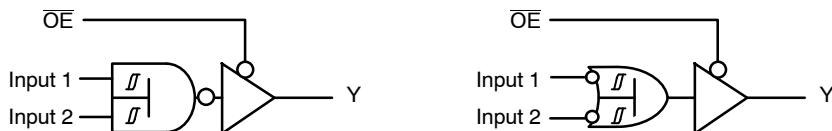


Figure 9.

| No. of Inputs | AND/NAND Function | OR/NOR Function | OE | A | B | C | D |
|---------------|------------------------------|--------------------------|----|--------|--------------------|--------------------|--------|
| 2 2 | 3-State NAND 3-State NAND | 3-State OR 3-State OR | L | L L | Input 1 Input 2 | Input 2 Input 1 | H H |

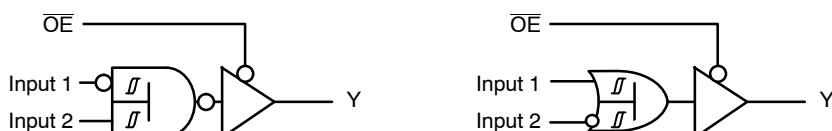


Figure 10.

| No. of Inputs | AND/NAND Function | OR/NOR Function | OE | A | B | C | D |
|---------------|------------------------------|--------------------------|----|--------------|--------------|--------------------|--------|
| 2 2 | 3-State NAND 3-State NAND | 3-State OR 3-State OR | L | Input 2 H | L Input 1 | Input 1 Input 2 | H L |

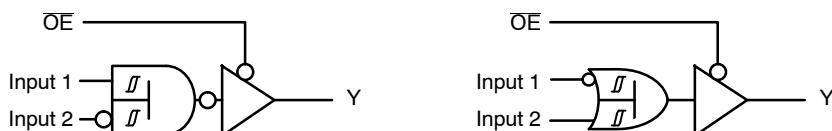


Figure 11.

| No. of Inputs | AND/NAND Function | OR/NOR Function | OE | A | B | C | D |
|---------------|------------------------------|--------------------------|----|--------------|--------------|--------------------|--------|
| 2 2 | 3-State NAND 3-State NAND | 3-State OR 3-State OR | L | Input 1 H | L Input 2 | Input 2 Input 1 | H L |



Figure 12.

| No. of Inputs | AND/NAND Function | OR/NOR Function | OE | A | B | C | D |
|---------------|----------------------------|--------------------------|----|--------------------|--------|--------------------|--------|
| 2 2 | 3-State AND 3-State AND | 3-State OR 3-State OR | L | Input 1 Input 2 | H H | Input 2 Input 1 | L L |

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3-State XOR/XNOR Function Available

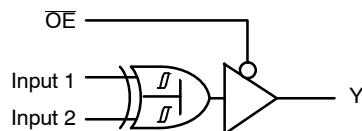


Figure 13.

| Function | \overline{OE} | A | B | C | D |
|-------------|-----------------|--|--|--|--|
| 3-State XOR | L | Input 1 Input 2 H or L H or L L L | H or L H or L Input 1 Input 2 H H | L L H H Input 1 Input 2 | Input 2 Input 1 Input 2 Input 1 Input 2 Input 1 |

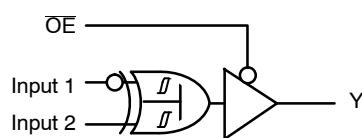


Figure 14.

| Function | \overline{OE} | A | B | C | D |
|-------------|-----------------|---|---|---------|---------|
| 3-State XOR | L | H | L | Input 1 | Input 2 |

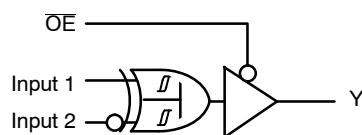


Figure 15.

| Function | \overline{OE} | A | B | C | D |
|-------------|-----------------|---|---|---------|---------|
| 3-State XOR | L | H | L | Input 1 | Input 2 |

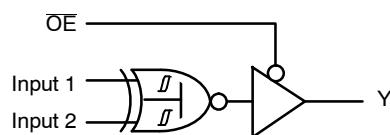


Figure 16.

| Function | \overline{OE} | A | B | C | D |
|------------------------------|-----------------|--------|--------|--------------------|--------------------|
| 3-State XNOR 3-State XNOR | L | H H | L L | Input 1 Input 2 | Input 2 Input 1 |

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MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
|---------------|---|------------------------|------|
| V_{CC} | DC Supply Voltage | -0.5 to +7.0 | V |
| V_{IN} | DC Input Voltage | -0.5 to +7.0 | V |
| V_{OUT} | DC Output Voltage | -0.5 to +7.0 | V |
| I_{IK} | DC Input Diode Current $V_{IN} < GND$ | -50 | mA |
| I_{OK} | DC Output Diode Current $V_{OUT} < GND$ | -50 | mA |
| I_O | DC Output Source/Sink Current | ± 50 | mA |
| I_{CC} | DC Supply Current Per Supply Pin | ± 100 | mA |
| I_{GND} | DC Ground Current per Ground Pin | ± 100 | mA |
| T_{STG} | Storage Temperature Range | -65 to +150 | °C |
| T_L | Lead Temperature, 1 mm from Case for 10 Seconds | 260 | °C |
| T_J | Junction Temperature Under Bias | 150 | °C |
| MSL | Moisture Sensitivity | Level 1 | |
| F_R | Flammability Rating Oxygen Index: 28 to 34 | UL 94 V-0 @ 0.125 in | |
| V_{ESD} | ESD Withstand Voltage Human Body Model (Note 2) Machine Model (Note 3) Charged Device Model (Note 4) | > 2000 > 200 N/A | V |
| $I_{LATCHUP}$ | Latchup Performance Above V_{CC} and Below GND at 125°C (Note 5) | ± 500 | mA |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Measured with minimum pad spacing on an FR4 board, using 10 mm-by-1 inch, 2 ounce copper trace no air flow.
2. Tested to EIA / JESD22-A114-A.
3. Tested to EIA / JESD22-A115-A.
4. Tested to JESD22-C101-A.
5. Tested to EIA / JESD78.

RECOMMENDED OPERATING CONDITIONS

| Symbol | Parameter | Min | Max | Unit |
|-----------------------|--|-------------|----------------------------------|------|
| V_{CC} | Positive DC Supply Voltage | 1.65 | 5.5 | V |
| V_{IN} | Digital Input Voltage | 0 | 5.5 | V |
| V_{OUT} | Output Voltage | 0 | 5.5 | V |
| T_A | Operating Free-Air Temperature | -55 | +125 | °C |
| $\Delta t / \Delta V$ | Input Transition Rise or Fall Rate $V_{CC} = 2.5 V \pm 0.2 V$ $V_{CC} = 3.3 V \pm 0.3 V$ $V_{CC} = 5.0 V \pm 0.5 V$ | 0 0 0 | No Limit No Limit No Limit | nS/V |

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DC ELECTRICAL CHARACTERISTICS

| Symbol | Parameter | Conditions | V _{CC} (V) | T _A = 25°C | | T _A ≤ +85°C | | T _A = -55°C to +125°C | | Unit |
|------------------|---------------------------------------|--|----------------------------------|---|--------------------------------------|--------------------------------------|------------------------------------|--------------------------------------|------------------------------------|------|
| | | | | Min | Max | Min | Max | Min | Max | |
| V _{T+} | Positive Threshold Voltage | | 1.65 2.3 3.0 4.5 5.5 | 0.79 1.11 1.5 1.87 2.16 2.61 | 1.16 1.56 1.87 2.74 3.33 | | | 1.16 1.56 1.87 2.74 3.33 | | V |
| V _{T-} | Negative Threshold Voltage | | 1.65 2.3 3.0 4.5 5.5 | 0.35 0.58 0.84 1.41 1.78 | 0.62 0.87 1.19 1.9 2.29 | 0.35 0.58 0.84 1.41 1.78 | | 0.35 0.58 0.84 1.41 1.78 | | V |
| V _H | Hysteresis Voltage | | 1.65 2.3 3.0 4.5 5.5 | 0.30 0.40 0.53 0.71 0.8 | 0.62 0.8 0.87 1.04 1.2 | 0.30 0.40 0.53 0.71 0.8 | 0.62 0.8 0.87 1.04 1.2 | 0.30 0.40 0.53 0.71 0.8 | 0.62 0.8 0.87 1.04 1.2 | V |
| V _{OH} | Minimum High-Level Output Voltage | V _{IN} = V _{T-MIN} or V _{T+MAX} I _{OH} = -50 µA | 1.65–5.5 | V _{CC} -0.1 | | V _{CC} -0.1 | | V _{CC} -0.1 | | V |
| | | V _{IN} = V _{T-MIN} or V _{T+MAX} I _{OH} = -4 mA I _{OH} = -8 mA I _{OH} = -16 mA I _{OH} = -24 mA I _{OH} = -32 mA | 1.65 2.3 3.0 3.0 4.5 | 1.2 1.9 2.4 2.3 3.8 | | 1.2 1.9 2.4 2.3 3.8 | | 1.2 1.9 2.4 2.3 3.8 | | V |
| V _{OL} | Maximum Low-Level Output Voltage | V _{IN} = V _{T-MIN} or V _{T+MAX} I _{OL} = 50 µA | 1.65–5.5 | | 0.1 | | 0.1 | | 0.1 | V |
| | | V _{IN} = V _{T-MIN} or V _{T+MAX} I _{OL} = 4 mA I _{OL} = 8 mA I _{OL} = 16 mA I _{OL} = 24 mA I _{OL} = 32 mA | 1.65 2.3 3.0 3.0 4.5 | | 0.45 0.3 0.4 0.55 0.55 | | 0.45 0.3 0.4 0.55 0.55 | | 0.45 0.3 0.4 0.55 0.55 | |
| I _{IN} | Input Leakage Current | 0 ≤ V _{IN} ≤ 5.5 V | 0 – 5.5 | | ±0.1 | | ±1.0 | | ±1.0 | µA |
| I _{off} | Power off Leakage Current | V _{IN} or V _O = 5.5 V | 0 | | ±1.0 | | ±10 | | ±10 | µA |
| I _{OZ} | Tri-state Output Leakage Current | V _O = V _{CC} or GND | 1.65–5.5 | | ±1.0 | | ±10 | | ±10 | µA |
| I _{CC} | Quiescent Supply Current | V _{IN} = V _{CC} or GND, I _O = 0 | 1.65–5.5 | | 1.0 | | 10 | | 10 | µA |
| ΔI _{CC} | Increase in I _{CC} Per Input | One input at (V _{CC} -0.6) V, other inputs at V _{CC} or GND | 3 – 5.5 | | 10 | | 100 | | 100 | µA |

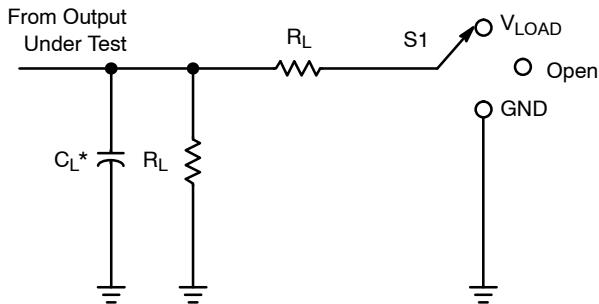
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AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 3.0$ ns)

| Symbol | Parameter | V_{CC} (V) | Test Condition | $T_A = 25^\circ C$ | | | $T_A \leq +85^\circ C$ | | $T_A = -55^\circ C$ to $+125^\circ C$ | | Unit |
|--------------------|---|--|--|--------------------------|---------------------------|----------------------------|--------------------------|----------------------------|---------------------------------------|----------------------------|------|
| | | | | Min | Typ | Max | Min | Max | Min | Max | |
| t_{PLH}, t_{PHL} | Propagation Delay, Any Input to Output Y (See Test Circuit) | 1.65–1.95 2.3 – 2.7 3.0 – 3.6 4.5 – 5.5 | Refer to switch positions and loading conditions in Figure 17 to 21. | 4.3 2.4 1.7 1.3 | 12.8 7.1 5.2 4.0 | 25.1 10.2 6.7 4.5 | 4.3 2.4 1.7 1.3 | 25.1 10.2 6.9 4.9 | 4.3 2.4 1.7 1.3 | 25.1 10.2 7.0 5.0 | ns |
| t_{EN} | Output Enable Time, \overline{OE} to Y | 1.65–1.95 2.3 – 2.7 3.0 – 3.6 4.5 – 5.5 | Refer to switch positions and loading conditions in Figure 17 to 21. | 3.4 2.1 1.3 1.0 | | 24.7 11 7.5 5.7 | 3.4 2.1 1.3 1.0 | 24.7 12 8.0 6.2 | 3.4 2.1 1.3 1.0 | 24.7 12.2 8.3 6.5 | ns |
| t_{DIS} | Output Disable Time, \overline{OE} to Y | 1.65–1.95 2.3 – 2.7 3.0 – 3.6 4.5 – 5.5 | Refer to switch positions and loading conditions in Figure 17 to 21. | 4.0 2.7 3.5 2.0 | | 15.5 7.5 7.0 5.5 | 4.0 2.7 3.5 2.0 | 15.5 7.5 7.0 5.5 | 4.0 2.7 3.5 2.0 | 15.5 7.5 7.0 5.5 | ns |
| t_{PLH}, t_{PHL} | Propagation Delay, Any Input to Output Y (See Test Circuit) | 1.65–1.95 2.3 – 2.7 3.0 – 3.6 4.5 – 5.5 | Refer to switch Positions and loading conditions in Figure 22 to 26. | 4.3 2.5 2.3 1.6 | 13.6 7.8 5.6 4.4 | 25.7 10.7 7.6 5.2 | 4.3 2.5 2.3 1.6 | 25.7 10.7 7.6 5.2 | 4.3 2.5 2.3 1.6 | 25.7 10.7 7.6 5.2 | ns |
| t_{EN} | Output Enable Time, \overline{OE} to Y | 1.65–1.95 2.3 – 2.7 3.0 – 3.6 4.5 – 5.5 | Refer to switch Positions and loading conditions in Figure 22 to 26. | 4.2 2.4 2.0 1.7 | | 25.2 11.3 8.0 6.0 | 4.2 2.4 2.0 1.7 | 25.2 12.2 8.5 6.5 | 4.2 2.4 2.0 1.7 | 25.2 13 8.7 6.7 | ns |
| t_{DIS} | Output Disable Time, \overline{OE} to Y | 1.65–1.95 2.3 – 2.7 3.0 – 3.6 4.5 – 5.5 | Refer to switch Positions and loading conditions in Figure 22 to 26. | 3.7 2.0 2.1 1.0 | | 15 6.5 5.6 4.5 | 3.7 2.0 2.1 1.0 | 15 6.7 5.8 4.7 | 3.7 2.0 2.1 1.0 | 15 6.9 5.9 4.9 | ns |
| C_{IN} | Input Capacitance | 3.3 | | | 3.5 | | | | | | pF |
| C_O | Output Capacitance | 3.3 | | | 6.0 | | | | | | pF |
| C_{PD} | Power Dissipation Capacitance (Note 6) | 3.3 | $f = 10$ MHz | | 22 | | | | | | pF |

6. C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the dynamic operating current consumption without load. Average operating current can be obtained by the equation $I_{CC(OPR)} = C_{PD} \cdot V_{CC} \cdot f_{in} + I_{CC}$. C_{PD} is used to determine the no-load dynamic power consumption: $P_D = C_{PD} \cdot V_{CC}^2 \cdot f_{in} + I_{CC} \cdot V_{CC}$.

TEST CIRCUIT AND VOLTAGE WAVEFORMS



| Test | S1 |
|-------------------|------------|
| t_{PLH}/t_{PHL} | Open |
| t_{PLZ}/t_{PZL} | V_{LOAD} |
| t_{PHZ}/t_{PZH} | GND |

* C_L includes probes and jig capacitance.

Figure 17. Load Circuit

| V_{CC} | Inputs | | V_M | V_{LOAD} | C_L | R_L | V_Δ |
|------------------------------------|----------|-----------------------|------------|-------------------|-------|---------------------|------------|
| | V_I | t_r/t_f | | | | | |
| $1.8 \text{ V} \pm 0.15 \text{ V}$ | V_{CC} | $\leq 2 \text{ ns}$ | $V_{CC}/2$ | $2 \times V_{CC}$ | 15 pF | $1 \text{ M}\Omega$ | 0.15 V |
| $2.5 \text{ V} \pm 0.2 \text{ V}$ | V_{CC} | $\leq 2 \text{ ns}$ | $V_{CC}/2$ | $2 \times V_{CC}$ | 15 pF | $1 \text{ M}\Omega$ | 0.15 V |
| $3.3 \text{ V} \pm 0.3 \text{ V}$ | 3 V | $\leq 2.5 \text{ ns}$ | 1.5 V | 6 V | 15 pF | $1 \text{ M}\Omega$ | 0.3 V |
| $5.5 \text{ V} \pm 0.5 \text{ V}$ | V_{CC} | $\leq 2.5 \text{ ns}$ | $V_{CC}/2$ | $2 \times V_{CC}$ | 15 pF | $1 \text{ M}\Omega$ | 0.3 V |

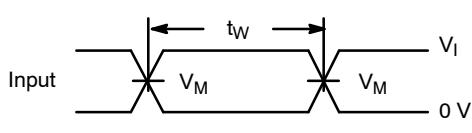


Figure 18. Voltage Waveforms Pulse Duration

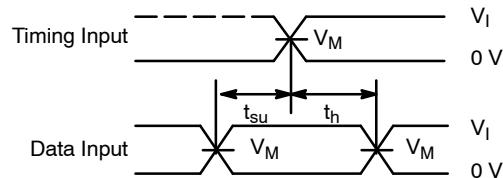


Figure 19. Voltage Waveforms Setup and Hold Times

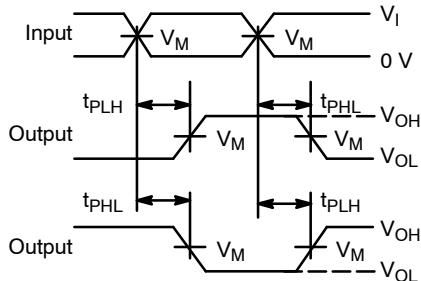


Figure 20. Voltage Waveforms Propagation Delay Times Inverting and Noninverting Outputs

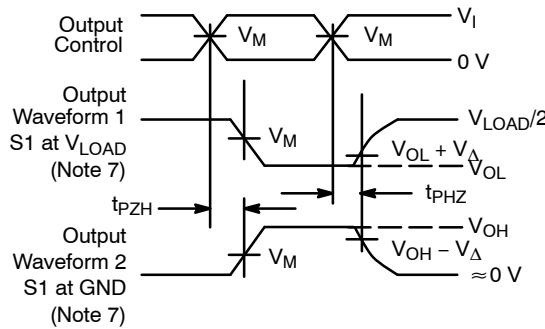
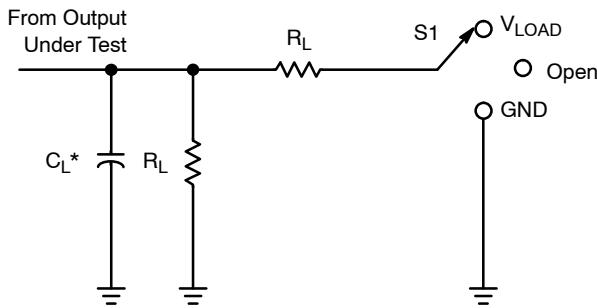


Figure 21. Voltage Waveforms Enable and Disable Times Low- and High-Level Enabling

7. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control.
8. All input pulses are supplied by generators having the following characteristics: PRR $\leq 10 \text{ MHz}$, $Z_O = 50 \Omega$.
9. The outputs are measured one at a time, with one transition per measurement.
10. All parameters are waveforms are not applicable to all devices.

NLX1G99



| Test | S1 |
|-------------------|------------|
| t_{PLH}/t_{PHL} | Open |
| t_{PLZ}/t_{PZL} | V_{LOAD} |
| t_{PHZ}/t_{PZH} | GND |

* C_L includes probes and jig capacitance.

Figure 22. Load Circuit

| V_{CC} | Inputs | | V_M | V_{LOAD} | C_L | R_L | V_Δ |
|------------------------------------|----------|-----------------------|------------|-------------------|-------|---------------------|------------|
| | V_I | t_r/t_f | | | | | |
| $1.8 \text{ V} \pm 0.15 \text{ V}$ | V_{CC} | $\leq 2 \text{ ns}$ | $V_{CC}/2$ | $2 \times V_{CC}$ | 30 pF | $1 \text{ k}\Omega$ | 0.15 V |
| $2.5 \text{ V} \pm 0.2 \text{ V}$ | V_{CC} | $\leq 2 \text{ ns}$ | $V_{CC}/2$ | $2 \times V_{CC}$ | 30 pF | 500Ω | 0.15 V |
| $3.3 \text{ V} \pm 0.3 \text{ V}$ | 3 V | $\leq 2.5 \text{ ns}$ | 1.5 V | 6 V | 50 pF | 500Ω | 0.3 V |
| $5.5 \text{ V} \pm 0.5 \text{ V}$ | V_{CC} | $\leq 2.5 \text{ ns}$ | $V_{CC}/2$ | $2 \times V_{CC}$ | 50 pF | 500Ω | 0.3 V |

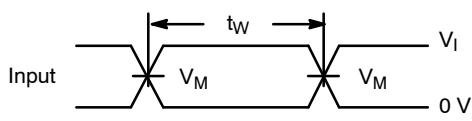


Figure 23. Voltage Waveforms Pulse Duration

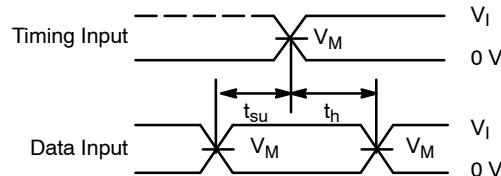


Figure 24. Voltage Waveforms Setup and Hold Times

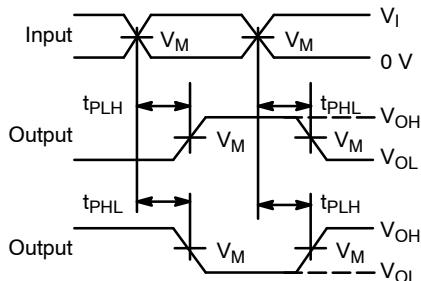


Figure 25. Voltage Waveforms Propagation Delay Times Inverting and Noninverting Outputs

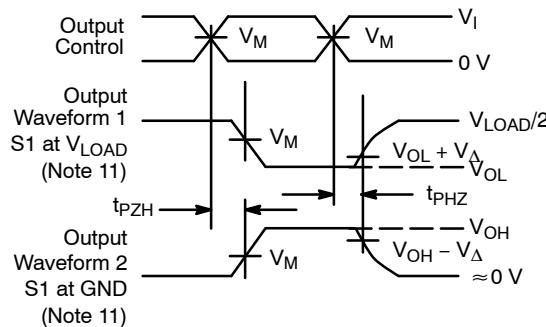


Figure 26. Voltage Waveforms Enable and Disable Times Low- and High-Level Enabling

11. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control.
12. All input pulses are supplied by generators having the following characteristics: PRR $\leq 10 \text{ MHz}$, $Z_O = 50 \Omega$.
13. The outputs are measured one at a time, with one transition per measurement.
14. All parameters are waveforms are not applicable to all devices.

NLX1G99

ORDERING INFORMATION

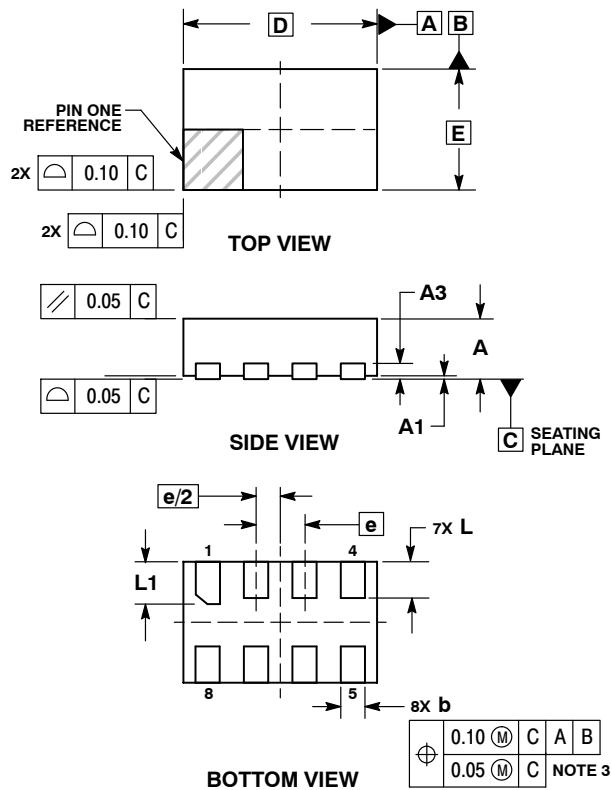
| Device | Package | Shipping [†] |
|---------------------------------|---------------------------------------|-----------------------|
| NLX1G99AMX1TCG | ULLGA8 – 0.5P (Pb-Free) | 3000 / Tape & Reel |
| NLX1G99BMX1TCG | ULLGA8 – 0.4P (Pb-Free) | 3000 / Tape & Reel |
| NLX1G99CMX1TCG | ULLGA8 – 0.35P (Pb-Free) | 3000 / Tape & Reel |
| NLX1G99DMUTCG | UDFN8, 1.95 x 1.0, 0.5P (Pb-Free) | 3000 / Tape & Reel |
| NLX1G99EMUTCG In Development | UDFN8, 1.6 x 1.0, 0.4P (Pb-Free) | 3000 / Tape & Reel |
| NLX1G99FMUTCG In Development | UDFN8, 1.45 x 1.0, 0.35P (Pb-Free) | 3000 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

NLX1G99

PACKAGE DIMENSIONS

UDFN8 1.6x1.0, 0.4P CASE 517BY ISSUE O



RECOMMENDED SOLDERING FOOTPRINT*

7X 0.49

8X 0.26

1.24

0.53

PKG OUTLINE

1

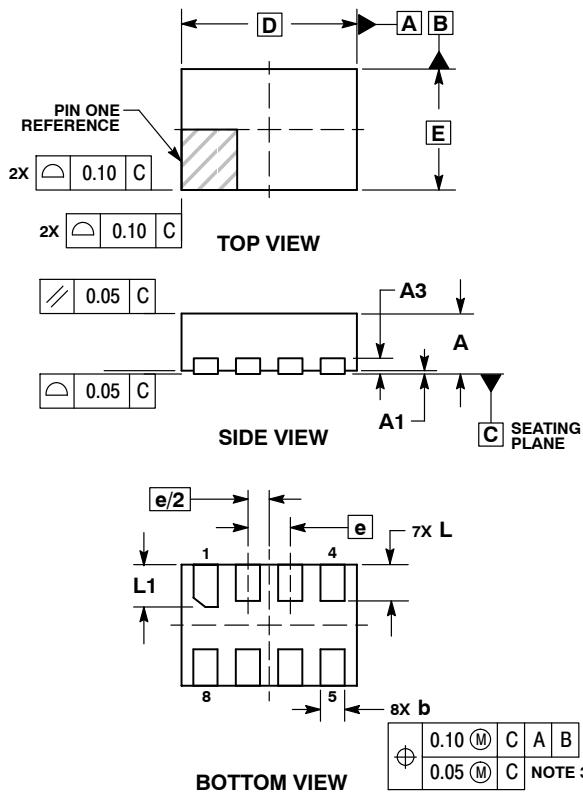
0.40 PITCH

DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

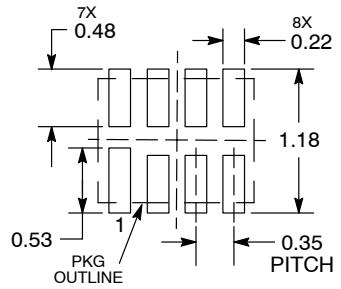
UDFN8 1.45x1.0, 0.35P
CASE 517BZ
ISSUE O



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20 MM FROM TERMINAL TIP.
4. PACKAGE DIMENSIONS EXCLUSIVE OF BURRS AND MOLD FLASH.

| DIM | MILLIMETERS | |
|-----|-------------|------|
| | MIN | MAX |
| A | 0.45 | 0.55 |
| A1 | 0.00 | 0.05 |
| A3 | 0.13 REF | |
| b | 0.15 | 0.25 |
| D | 1.45 BSC | |
| E | 1.00 BSC | |
| e | 0.35 BSC | |
| L | 0.25 | 0.35 |
| L1 | 0.30 | 0.40 |

RECOMMENDED SOLDERING FOOTPRINT*

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

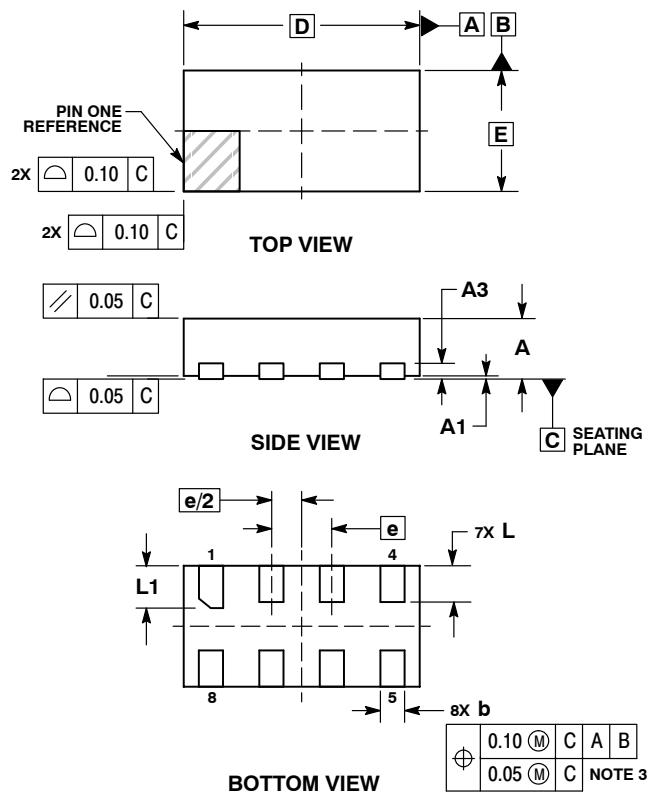
NLX1G99

PACKAGE DIMENSIONS

UDFN8 1.95x1.0, 0.5P

CASE 517CA

ISSUE O

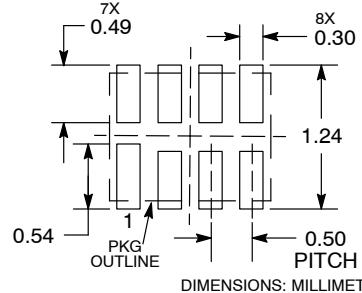


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20 MM FROM TERMINAL TIP.
4. PACKAGE DIMENSIONS EXCLUSIVE OF BURRS AND MOLD FLASH.

| MILLIMETERS | | |
|-------------|----------|------|
| DIM | MIN | MAX |
| A | 0.45 | 0.55 |
| A1 | 0.00 | 0.05 |
| A3 | 0.13 REF | |
| b | 0.15 | 0.25 |
| D | 1.95 BSC | |
| E | 1.00 BSC | |
| e | 0.50 BSC | |
| L | 0.25 | 0.35 |
| L1 | 0.30 | 0.40 |

RECOMMENDED SOLDERING FOOTPRINT*



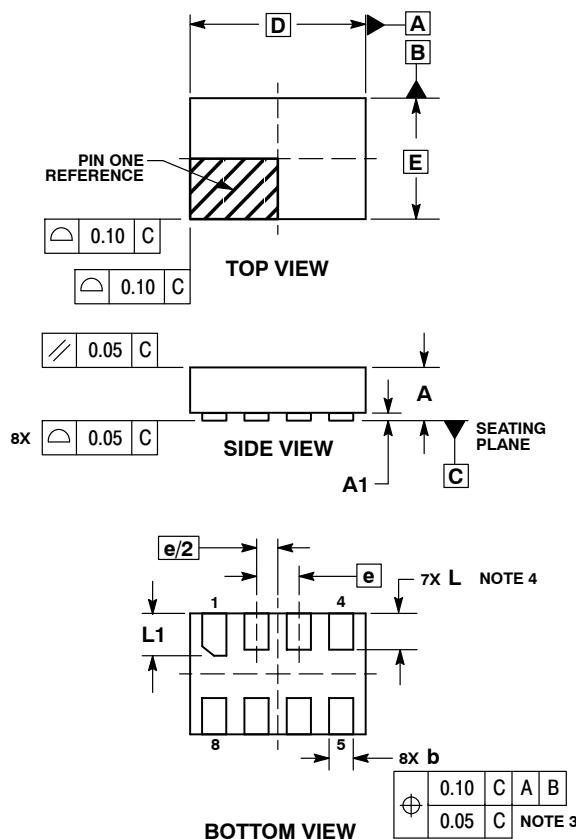
*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

ULLGA8 1.45x1.0, 0.35P

CASE 613AA

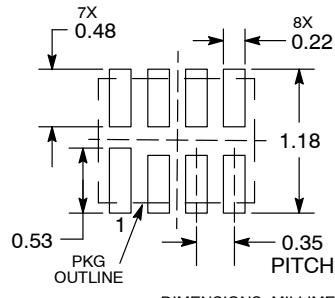
ISSUE A



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM THE TERMINAL TIP.
4. A MAXIMUM OF 0.05 PULL BACK OF THE PLATED TERMINAL FROM THE EDGE OF THE PACKAGE IS ALLOWED.

| MILLIMETERS | | |
|-------------|----------|------|
| DIM | MIN | MAX |
| A | --- | 0.40 |
| A1 | 0.00 | 0.05 |
| b | 0.15 | 0.25 |
| D | 1.45 BSC | |
| E | 1.00 BSC | |
| e | 0.35 BSC | |
| L | 0.25 | 0.35 |
| L1 | 0.30 | 0.40 |

MOUNTING FOOTPRINT
SOLDERMASK DEFINED*

DIMENSIONS: MILLIMETERS

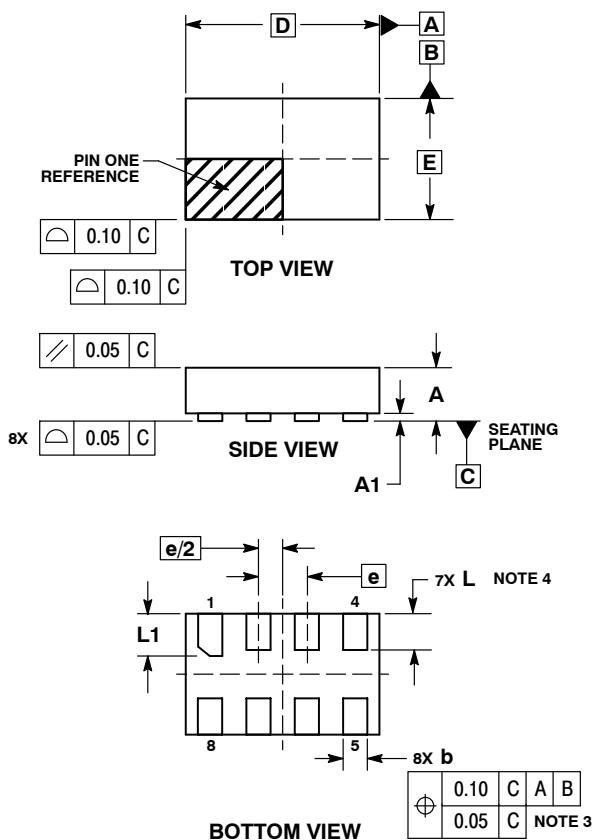
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PACKAGE DIMENSIONS

ULLGA8 1.6x1.0, 0.4P

CASE 613AB

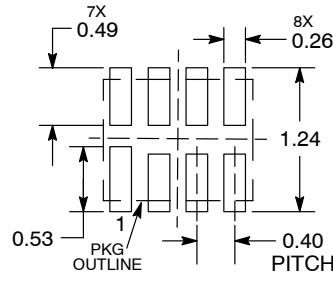
ISSUE A



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM THE TERMINAL TIP.
4. A MAXIMUM OF 0.05 PULL BACK OF THE PLATED TERMINAL FROM THE EDGE OF THE PACKAGE IS ALLOWED.

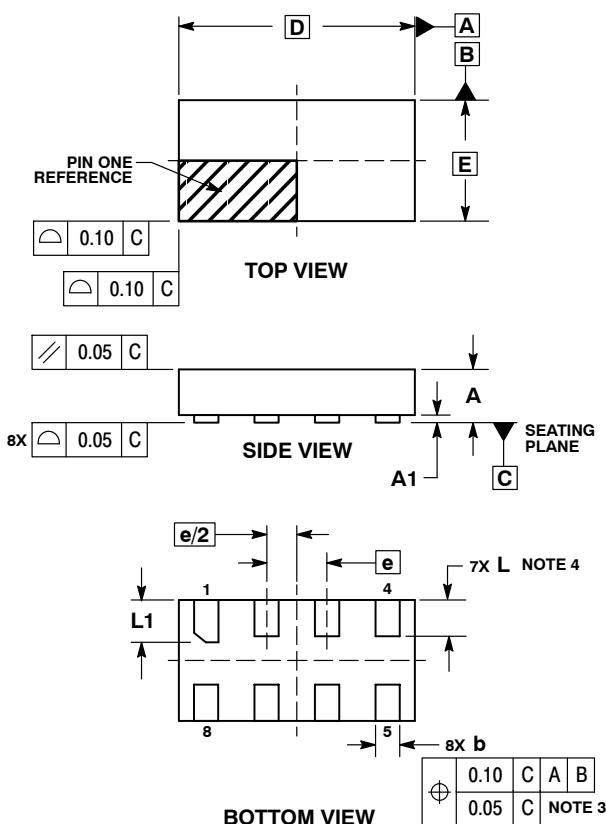
| DIM | MILLIMETERS | |
|-----|-------------|------|
| | MIN | MAX |
| A | --- | 0.40 |
| A1 | 0.00 | 0.05 |
| b | 0.15 | 0.25 |
| D | 1.60 BSC | |
| E | 1.00 BSC | |
| e | 0.40 BSC | |
| L | 0.25 | 0.35 |
| L1 | 0.30 | 0.40 |

MOUNTING FOOTPRINT
SOLDERMASK DEFINED*

DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

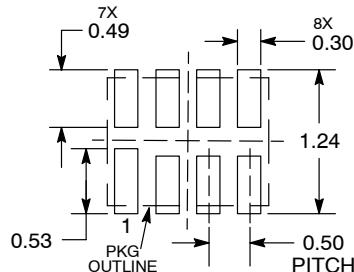
PACKAGE DIMENSIONS

ULLGA8 1.95x1.0, 0.5P
CASE 613AC
ISSUE A


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION *b* APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM THE TERMINAL TIP.
4. A MAXIMUM OF 0.05 PULL BACK OF THE PLATED TERMINAL FROM THE EDGE OF THE PACKAGE IS ALLOWED.

| MILLIMETERS | | |
|-------------|----------|------|
| DIM | MIN | MAX |
| A | --- | 0.40 |
| A1 | 0.00 | 0.05 |
| b | 0.15 | 0.25 |
| D | 1.95 BSC | |
| E | 1.00 BSC | |
| e | 0.50 BSC | |
| L | 0.25 | 0.35 |
| L1 | 0.30 | 0.40 |

**MOUNTING FOOTPRINT
SOLDERMASK DEFINED***


DIMENSIONS: MILLIMETERS

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